Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	100.0 x 20.0 x 10.0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	FRONT, 0.00	D2450	CW, 0	2450.0, 50	8.18	1.85	39.4

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2178	HSL600-10000 Charge: xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29
	2022-Aug-31		

Scan Setup

Scan Setup	Measurement Results				
•	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 140.0	30.0 x 30.0 x 30.0	Date	2022-09-16, 15:30	2022-09-16, 15:37
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5	psSAR1g [W/kg]	12.9	12.8
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	6.12	5.97
Graded Grid	Yes	Yes	Power Drift [dB]	0.00	-0.01
Grading Ratio	1.5	1.5	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		80.6
			Dist 3dB Peak [mm]		9.0

Zoom Scan

Warning(s) / Error(s)

Details Area Scan Warning(s) Error(s)

